

Search Notes

Application/Control No.

10/586,287

Examiner

RIP A. LEE

Applicant(s)/Patent under
Reexamination

CHEN ET AL.

Art Unit

1762

SEARCHED

Class	Subclass	Date	Examiner
556	143	4/20/2011	RL
556	144	4/20/2011	RL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
556	143	4/20/2011	RL
556	144	4/20/2011	RL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east - updated search	4/20/2011	RL
palm/eDAN inventor search updated	4/20/2011	RL